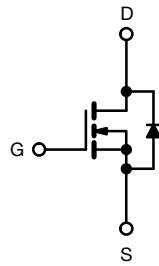
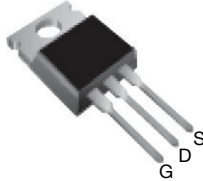


EF Series Power MOSFET With Fast Body Diode

TO-220AB



N-Channel MOSFET

FEATURES

- A specific on resistance ($m\Omega\text{-cm}^2$) reduction of 25 %
- Low figure-of-merit (FOM) $R_{\text{on}} \times Q_g$
- Low input capacitance (C_{iss})
- Reduced switching and conduction losses
- Ultra low gate charge (Q_g)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912


RoHS
 COMPLIANT
 HALOGEN
FREE

PRODUCT SUMMARY

V_{DS} (V) at T_J max.	650	
$R_{\text{DS(on)}}$ typ. (Ω) at 25 °C	$V_{\text{GS}} = 10 \text{ V}$	0.084
Q_g max. (nC)	134	
Q_{gs} (nC)	16	
Q_{gd} (nC)	48	
Configuration	Single	

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

ORDERING INFORMATION

Package	TO-220AB
Lead (Pb)-free and halogen-free	SiHP35N60EF-GE3

ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ }^\circ\text{C}$, unless otherwise noted)


PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-source voltage	V_{DS}	600	V	
Gate-source voltage	V_{GS}	± 30		
Continuous drain current ($T_J = 150 \text{ }^\circ\text{C}$)	V_{GS} at 10 V	$T_C = 25 \text{ }^\circ\text{C}$	32	A
		$T_C = 100 \text{ }^\circ\text{C}$	20	
Pulsed drain current ^a	I_{DM}	80		
Linear derating factor		2.0	W/ $^\circ\text{C}$	
Single pulse avalanche energy ^b	E_{AS}	298	mJ	
Maximum power dissipation	P_D	250	W	
Operating junction and storage temperature range	T_J, T_{stg}	-55 to +150	$^\circ\text{C}$	
Drain-source voltage slope	dv/dt	100	V/ns	
Reverse diode dv/dt ^d				50
Soldering recommendations (peak temperature) ^c	For 10 s	260	$^\circ\text{C}$	

Notes

- Repetitive rating; pulse width limited by maximum junction temperature
- $V_{\text{DD}} = 140 \text{ V}$, starting $T_J = 25 \text{ }^\circ\text{C}$, $L = 28.2 \text{ mH}$, $R_g = 25 \text{ } \Omega$, $I_{\text{AS}} = 4.6 \text{ A}$
- 1.6 mm from case
- $I_{\text{SD}} = 17 \text{ A}$, $di/dt = 300 \text{ A}/\mu\text{s}$, starting $T_J = 25 \text{ }^\circ\text{C}$



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	-	62	°C/W
Maximum junction-to-case (drain)	R _{thJC}	-	0.5	

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		600	-	-	V
V _{DS} temperature coefficient	ΔV _{DS} /T _J	Reference to 25 °C, I _D = 10 mA		-	0.66	-	V/°C
Gate-source threshold voltage (N)	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA		2.0	-	4.0	V
Gate-source leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
		V _{GS} = ± 30 V		-	-	± 1	μA
Zero gate voltage drain current	I _{DSS}	V _{DS} = 480 V, V _{GS} = 0 V		-	-	1	μA
		V _{DS} = 480 V, V _{GS} = 0 V, T _J = 125 °C		-	-	500	
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 17 A	-	0.084	0.097	Ω
Forward transconductance ^a	g _{fs}	V _{DS} = 30 V, I _D = 17 A		-	8	-	S
Dynamic							
Input capacitance	C _{iSS}	V _{GS} = 0 V, V _{DS} = 100 V, f = 1 MHz		-	2568	-	pF
Output capacitance	C _{oss}			-	113	-	
Reverse transfer capacitance	C _{rSS}			-	7	-	
Effective output capacitance, energy related ^a	C _{o(er)}			-	81	-	
Effective output capacitance, time related ^b	C _{o(tr)}	V _{DS} = 0 V to 480 V, V _{GS} = 0 V		-	421	-	
Total gate charge	Q _g	V _{GS} = 10 V	I _D = 17 A, V _{DS} = 480 V	-	89	134	nC
Gate-source charge	Q _{gs}			-	16	-	
Gate-drain charge	Q _{gd}			-	48	-	
Turn-on delay time	t _{d(on)}	V _{DD} = 480 V, I _D = 17 A, V _{GS} = 10 V, R _g = 9.1 Ω		-	28	56	ns
Rise time	t _r			-	85	170	
Turn-off delay time	t _{d(off)}			-	96	192	
Fall time	t _f			-	61	122	
Gate input resistance	R _g	f = 1 MHz, open drain		0.2	0.5	1.0	Ω
Drain-Source Body Diode Characteristics							
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode 		-	-	32	A
Pulsed diode forward current	I _{SM}			-	-	80	
Diode forward voltage	V _{SD}	T _J = 25 °C, I _S = 17 A, V _{GS} = 0 V		-	-	1.2	V
Reverse recovery time	t _{rr}	T _J = 25 °C, I _F = I _S = 17 A, di/dt = 100 A/μs, V _R = 400 V		-	150	300	ns
Reverse recovery charge	Q _{rr}			-	1.1	2.2	μC
Reverse recovery current	I _{RRM}			-	14	-	A

Notes

- a. C_{oss(er)} is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}
- b. C_{oss(tr)} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

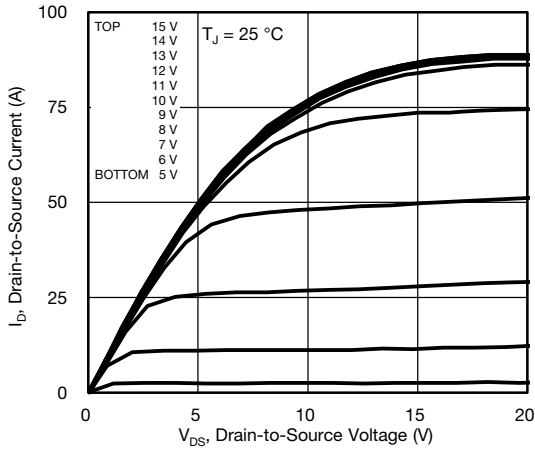


Fig. 1 - Typical Output Characteristics

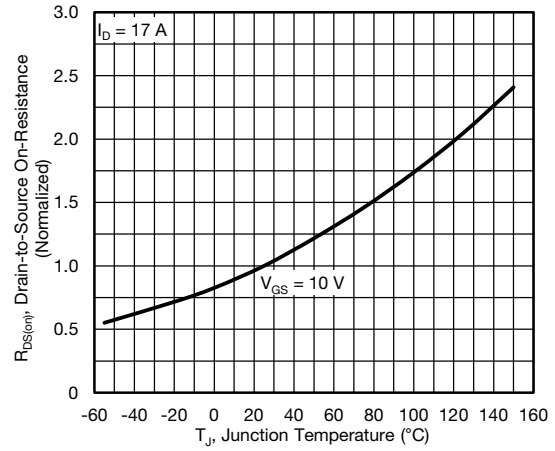


Fig. 4 - Normalized On-Resistance vs. Temperature

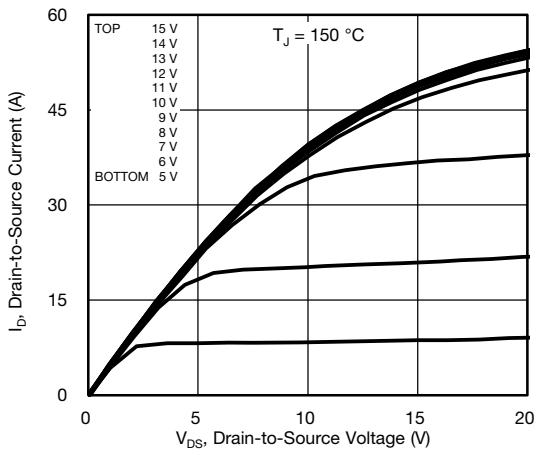


Fig. 2 - Typical Output Characteristics

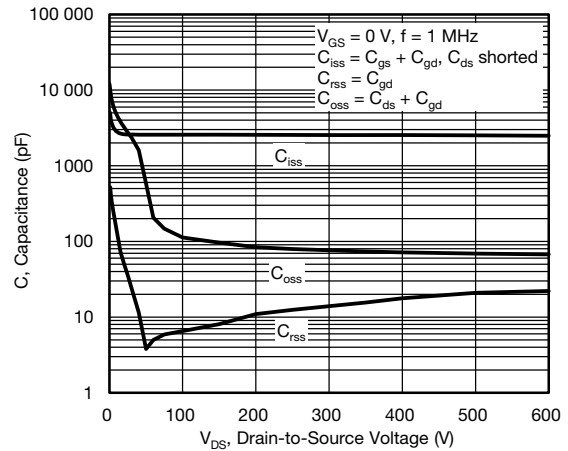


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

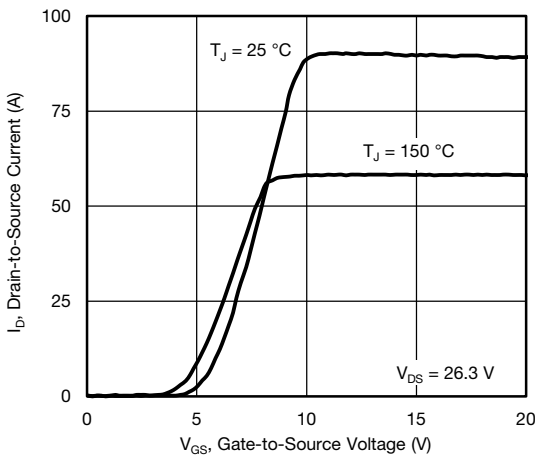


Fig. 3 - Typical Transfer Characteristics

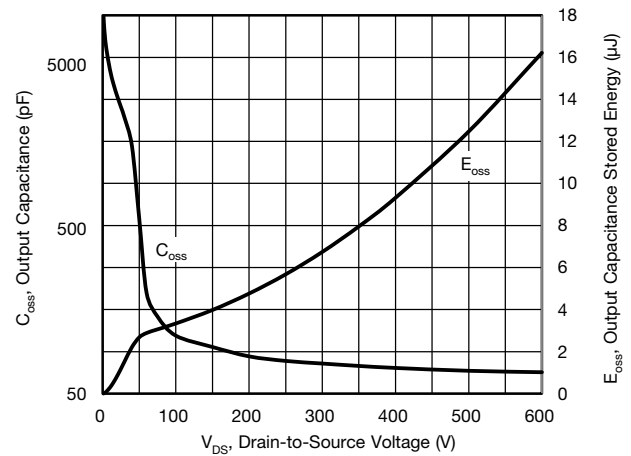


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}

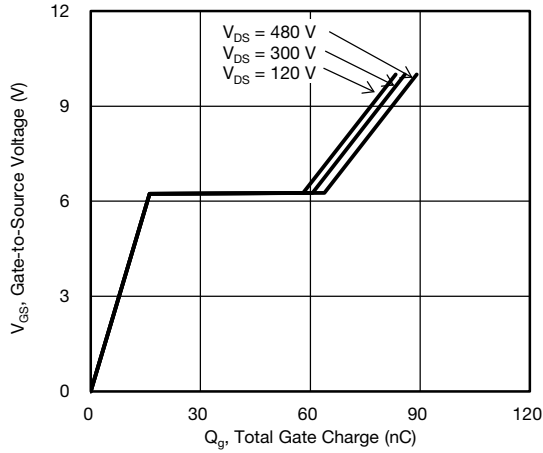


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

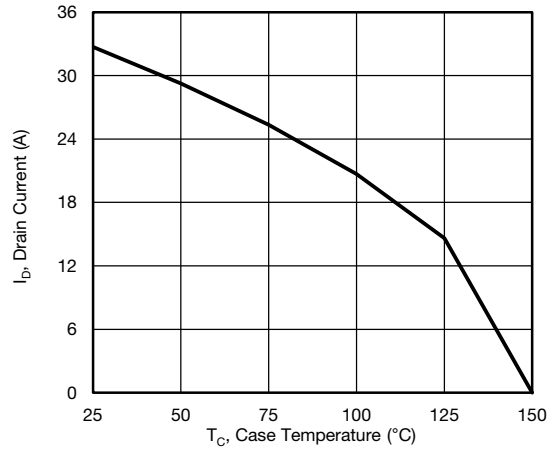


Fig. 10 - Maximum Drain Current vs. Case Temperature

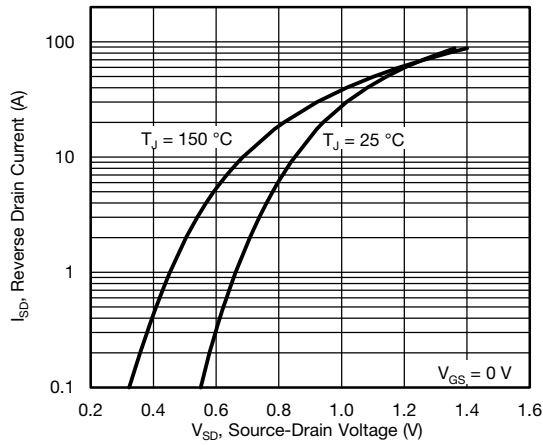


Fig. 8 - Typical Source-Drain Diode Forward Voltage

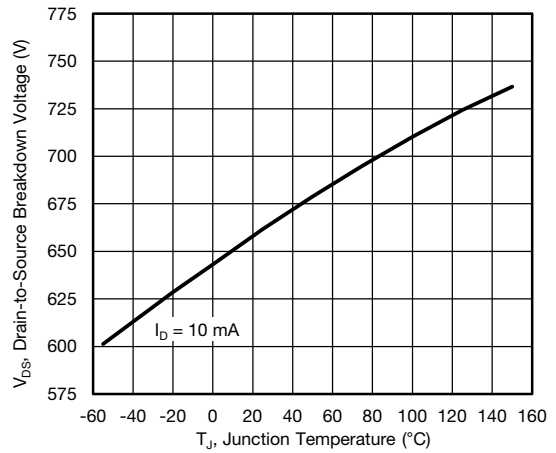


Fig. 11 - Temperature vs. Drain-to-Source Voltage

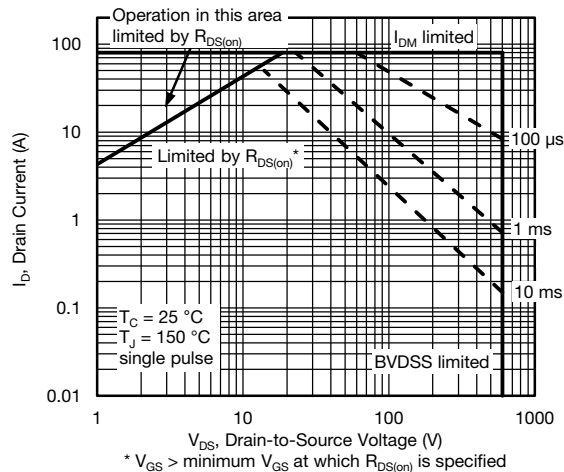


Fig. 9 - Maximum Safe Operating Area

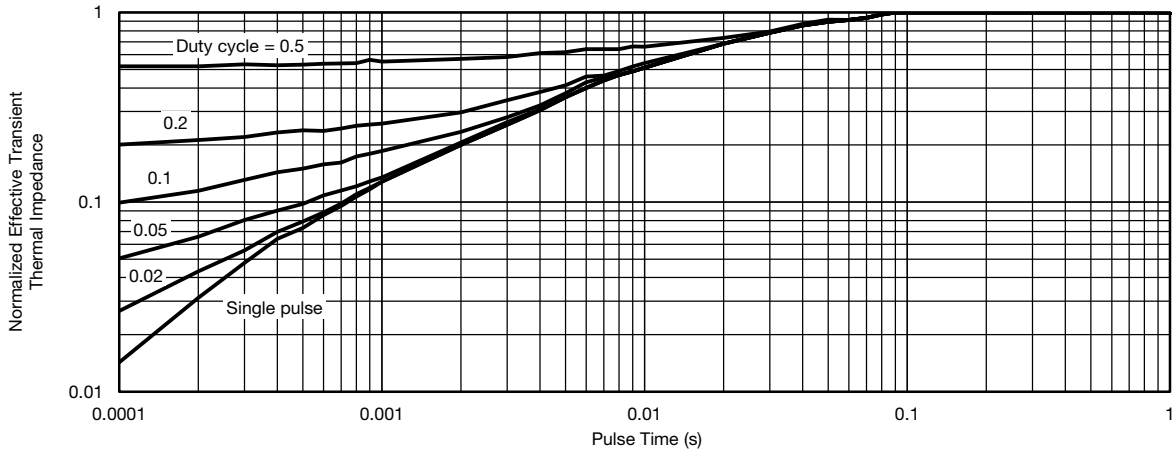


Fig. 12 - Normalized Transient Thermal Impedance, Junction-to-Case

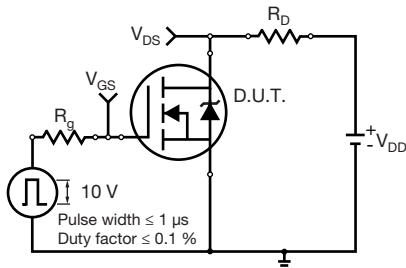


Fig. 13 - Switching Time Test Circuit

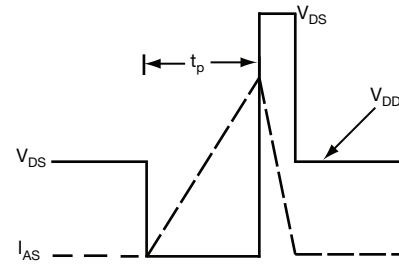


Fig. 16 - Unclamped Inductive Waveforms

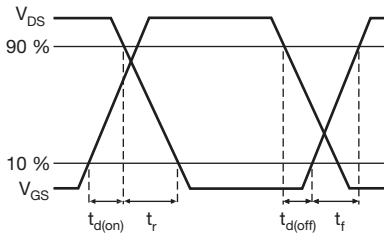


Fig. 14 - Switching Time Waveforms

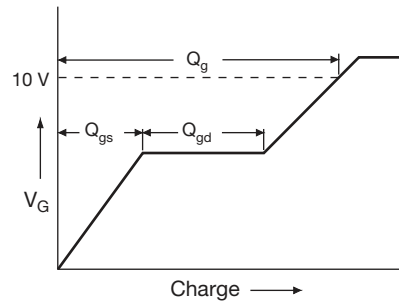


Fig. 17 - Basic Gate Charge Waveform

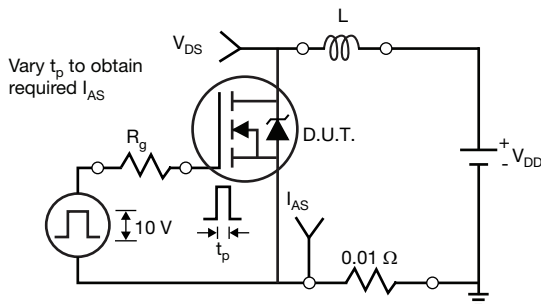


Fig. 15 - Unclamped Inductive Test Circuit

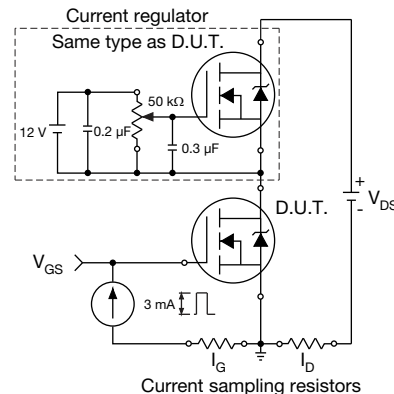
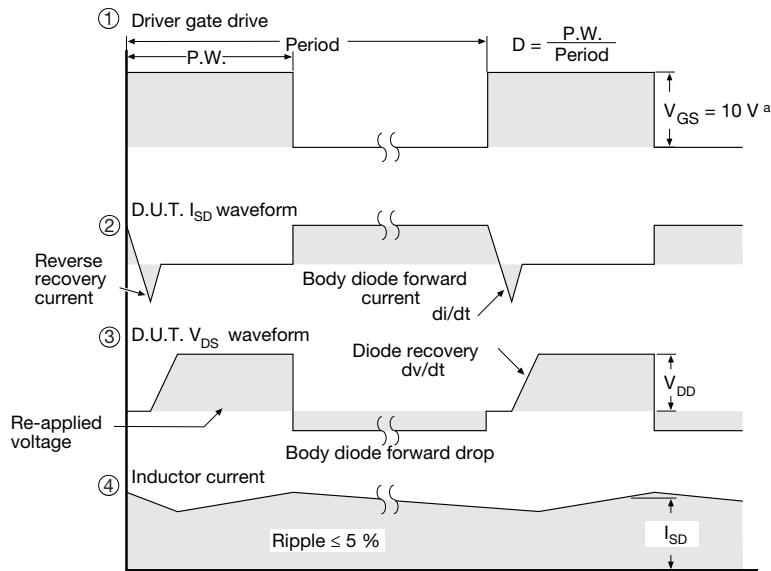
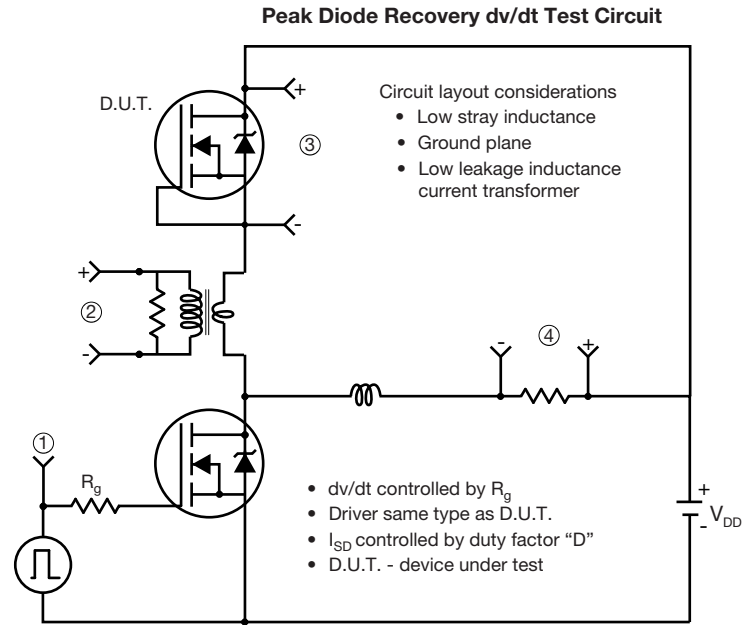


Fig. 18 - Gate Charge Test Circuit



Note
a. $V_{GS} = 5\text{ V}$ for logic level devices

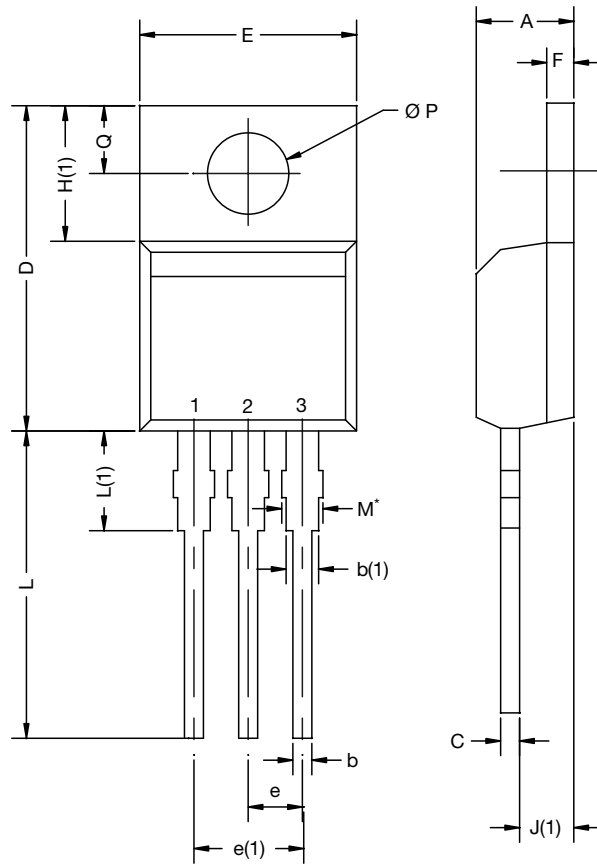
Fig. 19 - For N-Channel

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Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?92107.

TO-220-1



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.24	4.65	0.167	0.183
b	0.69	1.02	0.027	0.040
b(1)	1.14	1.78	0.045	0.070
c	0.36	0.61	0.014	0.024
D	14.33	15.85	0.564	0.624
E	9.96	10.52	0.392	0.414
e	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.10	6.71	0.240	0.264
J(1)	2.41	2.92	0.095	0.115
L	13.36	14.40	0.526	0.567
L(1)	3.33	4.04	0.131	0.159
Ø P	3.53	3.94	0.139	0.155
Q	2.54	3.00	0.100	0.118

ECN: E21-0621-Rev. D, 04-Nov-2021
DWG: 6031

Note

- M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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